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ECL Products	

100163

Dual 8-Input Multiplexer

FEATURES

- Typical propagation delay: 1.25ns
- Typical supply current ($-I_{EE}$): 125mA

DESCRIPTION

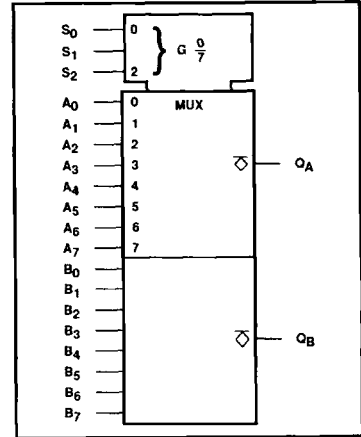
The 100163 circuit is a dual 8-input multiplexer. The three data select inputs ($S_0 - S_2$) switch one of the eight data inputs in each multiplexer to its corresponding output.

All unused inputs can be left open due to integrated pull-down resistors.

PIN DESCRIPTION

PINS	DESCRIPTION
$A_0 - A_7$, $B_0 - B_7$	Data Inputs
$S_0 - S_2$	Data Select Inputs
Q_A , Q_B	Data Outputs

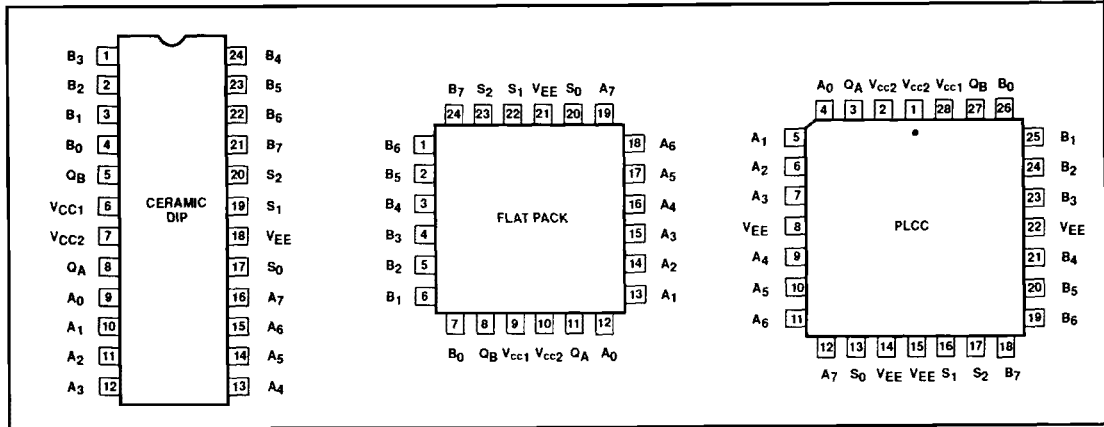
IEC/IEEE SYMBOL



ORDERING INFORMATION

DESCRIPTION	ORDER CODE
24-Pin Ceramic DIP (400 mils wide)	100163F
24-Pin Ceramic Flat Pack	100163Y
28-Pin PLCC	100163A

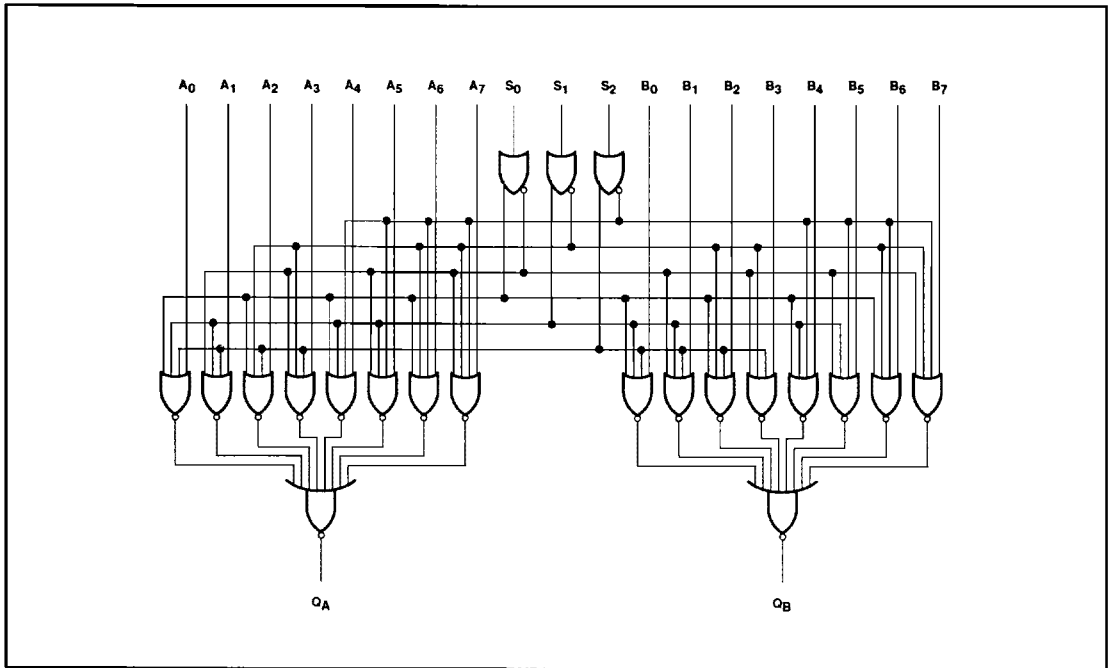
PIN CONFIGURATIONS



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LOGIC DIAGRAM



FUNCTION TABLE

Select			INPUTS								OUTPUTS	
S ₂	S ₁	S ₀	Data								Q _A Q _B	
			A ₇ B ₇	A ₆ B ₆	A ₅ B ₅	A ₄ B ₄	A ₃ B ₃	A ₂ B ₂	A ₁ B ₁	A ₀ B ₀		
L	L	L	X	X	X	X	X	X	X	X	L	L
L	L	L	X	X	X	X	X	X	X	X	H	H
L	L	H	X	X	X	X	X	X	X	L	X	L
L	L	H	X	X	X	X	X	X	X	H	X	H
L	H	L	X	X	X	X	X	L	X	X	X	L
L	H	L	X	X	X	X	X	H	X	X	X	H
L	H	H	X	X	X	X	L	X	X	X	X	L
L	H	H	X	X	X	X	H	X	X	X	X	H
H	L	L	X	X	X	L	X	X	X	X	X	L
H	L	L	X	X	X	H	X	X	X	X	X	H
H	L	H	X	X	L	X	X	X	X	X	X	L
H	L	H	X	X	H	X	X	X	X	X	X	H
H	H	L	X	L	X	X	X	X	X	X	X	L
H	H	L	X	H	X	X	X	X	X	X	X	H
H	H	H	L	X	X	X	X	X	X	X	X	L
H	H	H	H	X	X	X	X	X	X	X	X	H

NOTES:

- H = High voltage level
- L = Low voltage level
- X = Don't care

Multiplexer**100163****ABSOLUTE MAXIMUM RATINGS** $V_{CC1} = V_{CC2} = \text{ground}$, $T_A = 0^\circ\text{C}$ to $+85^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	LIMITS	UNIT
V_{EE}	Supply voltage range	-7.0 to +0.5	V
V_{IN}	Input voltage (V_{IN} should never be more negative than V_{EE})	V_{EE} to +0.5	V
I_O	Output source current (continuous)	-55	mA
T_S	Storage temperature range	-65 to +150	$^\circ\text{C}$
T_J	Maximum junction temperature	+150	$^\circ\text{C}$

NOTE:

Operation beyond the limits set forth in this table may impair the useful life of the device.

DC OPERATING CONDITIONS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN.	NOM.	MAX.	
V_{CC1}, V_{CC2}	Circuit ground		0	0	0	V
V_{EE}	Supply voltage		-4.8	-4.5	-4.2	V
V_{EE}	Supply voltage when operating with the 10K or the 10KH ECL family		-5.7			V
V_{IH}	High level input voltage	$V_{EE} = -4.2\text{V}$	-1150		-880	mV
		$V_{EE} = -4.5\text{V}$	-1165			
		$V_{EE} = -4.8\text{V}$	-1165			
V_{IL}	Low level input voltage	$V_{EE} = -4.2\text{V}$	-1810		-1475	mV
		$V_{EE} = -4.5\text{V}$			-1475	mV
		$V_{EE} = -4.8\text{V}$			-1490	mV
T_A	Operating ambient temperature range		0	+25	+85	$^\circ\text{C}$

NOTE:

When operating at other than the specified V_{EE} voltages (-4.2V, -4.5V, -4.8V), the DC and AC electrical characteristics will vary slightly from their specified values.

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DC ELECTRICAL CHARACTERISTICS $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -4.8\text{V to } -4.2\text{V}$, $T_A = 0^\circ\text{C to } +85^\circ\text{C}$ unless otherwise specified^{1,3,4}

SYMBOL	PARAMETER	TEST CONDITIONS ²			LIMITS			UNIT		
					MIN.	TYP.	MAX.			
V_{OH}	High level output voltage	Outputs loaded with 50Ω to -2.0V $\pm 0.010\text{V}$	Inputs at V_{IHMAX} or V_{ILMIN}	$V_{EE} = -4.2\text{V}$	-1020		-870	mV		
				$V_{EE} = -4.5\text{V}$	-1025	-955	-880	mV		
				$V_{EE} = -4.8\text{V}$	-1035		-880	mV		
V_{OHT}	High level output threshold voltage		Outputs loaded with 50Ω to -2.0V $\pm 0.010\text{V}$	Apply V_{IHMIN} or V_{ILMAX} to one input at a time. Other inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2\text{V}$	-1030			mV	
					$V_{EE} = -4.5\text{V}$	-1035			mV	
					$V_{EE} = -4.8\text{V}$	-1045			mV	
V_{OLT}	Low level output threshold voltage			Outputs loaded with 50Ω to -2.0V $\pm 0.010\text{V}$	Apply V_{IHMIN} or V_{ILMAX} to one input at a time. Other inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2\text{V}$			-1595	mV
						$V_{EE} = -4.5\text{V}$			-1610	mV
						$V_{EE} = -4.8\text{V}$			-1610	mV
V_{OL}	Low level output voltage	Outputs loaded with 50Ω to -2.0V $\pm 0.010\text{V}$			Inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2\text{V}$	-1810		-1605	mV
						$V_{EE} = -4.5\text{V}$	-1810	-1705	-1620	mV
						$V_{EE} = -4.8\text{V}$	-1830		-1620	mV
I_{IH}	High level input current		S_n		One input under test at V_{IHMAX} . Other inputs at V_{ILMIN} .				265	μA
			A_n, B_n						340	μA
I_{IL}	Low level input current				One input under test at V_{ILMIN} . Other inputs at V_{IHMAX} .		0.5			μA
$-I_{EE}$	V_{EE} supply current			All inputs at V_{IHMAX}		76	125	161	mA	

NOTES:

- The specified limits represent the worst case values for the parameter. Since these worst case values normally occur at the supply voltage and temperature extremes, additional noise immunity can be achieved by decreasing the allowable operating condition ranges.
- Conditions for testing shown in the tables are not necessarily worst case. For worst case testing guidelines, refer to DC Testing, Chapter 1, Section 3.
- The specified limits shown in the DC electrical characteristics table can be met only after thermal equilibrium has been established. Thermal equilibrium is established by applying power for at least 2 minutes, while maintaining transverse airflow of 2.5 meters/sec (500 linear feet/min) over the device, mounted either in a test socket or on a printed circuit board. Test voltage values are given in the DC operating conditions table.
- The device can function down to $V_{EE} = -5.7\text{V}$, allowing operation with either the 10K or the 10KH family. Correction factors can be used to calculate new DC limits for the extended V_{EE} range. For more information, see Chapters 5 and 10, Section 4.

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AC ELECTRICAL CHARACTERISTICS

Ceramic DIP $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -4.2\text{V to } -4.8\text{V}$

SYMBOL	PARAMETER	TEST CONDITION	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
t_{PLH} t_{PHL}	Propagation delay A_n, B_n to Q_A, Q_B	Waveform 1	0.55	1.90	0.60	1.90	0.65	2.00	ns
			0.55	1.90	0.60	1.90	0.65	2.00	ns
t_{PLH} t_{PHL}	Propagation delay S_n to Q_A, Q_B		1.10	2.80	1.10	2.80	1.20	3.10	ns
			1.10	2.80	1.10	2.80	1.20	3.10	ns
t_{TLH} t_{THL}	Transition time Q_A, Q_B		0.50	1.75	0.50	1.70	0.50	1.70	ns
			0.50	1.75	0.50	1.70	0.50	1.70	ns

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

AC ELECTRICAL CHARACTERISTICS

Ceramic DIP $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -5.2\text{V} \pm 5\%$

SYMBOL	PARAMETER	TEST CONDITION	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
t_{PLH} t_{PHL}	Propagation delay A_n, B_n to Q_A, Q_B	Waveform 1	0.55	1.90	0.60	1.90	0.65	2.00	ns
			0.55	1.90	0.60	1.90	0.65	2.00	ns
t_{PLH} t_{PHL}	Propagation delay S_n to Q_A, Q_B		1.10	2.80	1.10	2.80	1.20	3.10	ns
			1.10	2.80	1.10	2.80	1.20	3.10	ns
t_{TLH} t_{THL}	Transition time Q_A, Q_B		0.50	1.75	0.50	1.70	0.50	1.70	ns
			0.50	1.75	0.50	1.70	0.50	1.70	ns

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

AC ELECTRICAL CHARACTERISTICS

Flat Pack and PLCC $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -4.2\text{V to } -4.8\text{V}$

SYMBOL	PARAMETER	TEST CONDITION	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
t_{PLH} t_{PHL}	Propagation delay A_n, B_n to Q_A, Q_B	Waveform 1	0.55	1.70	0.60	1.70	0.65	1.80	ns
			0.55	1.70	0.60	1.70	0.65	1.80	ns
t_{PLH} t_{PHL}	Propagation delay S_n to Q_A, Q_B		1.10	2.60	1.10	2.60	1.20	2.90	ns
			1.10	2.60	1.10	2.60	1.20	2.90	ns
t_{TLH} t_{THL}	Transition time Q_A, Q		0.50	1.75	0.50	1.70	0.50	1.70	ns
			0.50	1.75	0.50	1.70	0.50	1.70	ns

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

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AC ELECTRICAL CHARACTERISTICS

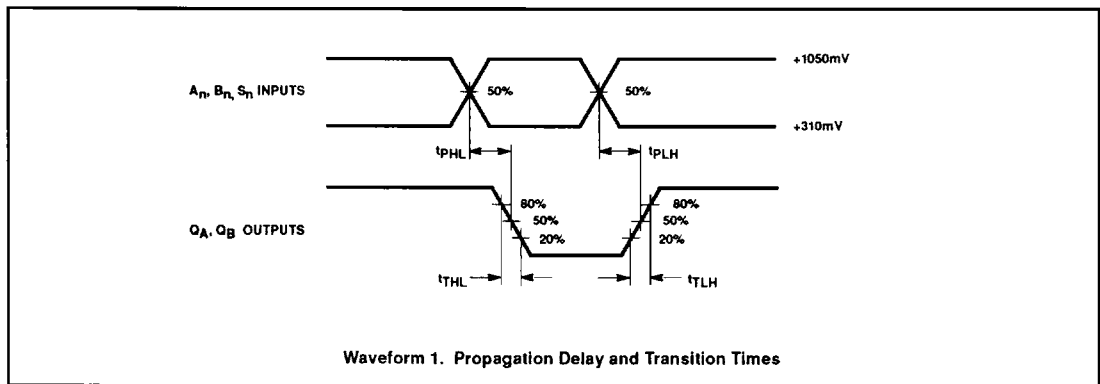
Flat Pack and PLCC $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -5.2V \pm 5\%$

SYMBOL	PARAMETER	TEST CONDITION	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
t_{PLH} t_{PHL}	Propagation delay A_n, B_n to Q_A, Q_B	Waveform 1	0.55	1.70	0.60	1.70	0.65	1.80	ns
t_{PLH} t_{PHL}	Propagation delay S_n to Q_A, Q_B		1.10	2.60	1.10	2.60	1.20	2.90	ns
t_{TLH} t_{THL}	Transition time Q_A, Q_B		0.50	1.75	0.50	1.70	0.50	1.70	ns
			0.55	1.70	0.60	1.70	0.65	1.80	ns
			1.10	2.60	1.10	2.60	1.20	2.90	ns
			0.50	1.75	0.50	1.70	0.50	1.70	ns

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

AC WAVEFORMS



NOTE:

All power and signal voltages shifted up 2.0V for AC bench test purposes.